Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/796,365	NEITZELL ET AL.	
Examiner	Art Unit	
Hwei-Siu C. Payer	3724	

SEARCHED					
Class	Subclass	Date	Examiner		
30	392	8/28/2007	H.P.		
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